

Search Notes

Application/Control No.

09/960,262

Examiner

David R. O'Steen

Applicant(s)/Patent under
Reexamination

CHAPIN ET AL.

Art Unit

2623

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(ATVEF definition from TechWeb)	7/19/2006	DRO